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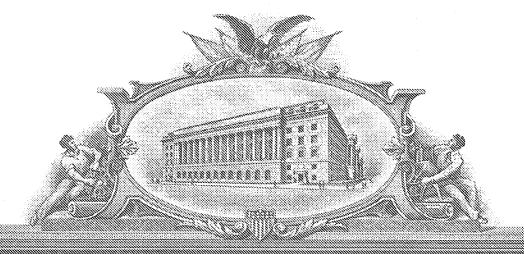
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PROVISIONAL APPLICATION FOR PATENT COVER SHEET

This is a request for filing a PROVISIONAL APPLICATION FOR PATENT under 37 CFR 1.53(c). ER380175151US **Express Mail Label No.** INVENTOR(S) Residence Given Name (first and middle [if any]) Family Name or Surname (City and either State or Foreign Country) Michael L. Columbia, SC Myrick Paul G. Miney Columbia, SC Maria V. Columbia, SC Schiza Additional inventors are being named on the separately numbered sheets attached hereto TITLE OF THE INVENTION (500 characters max) Thin-Layer Porous Optical Interferometric Sensors for Gases and Other Fluids **CORRESPONDENCE ADDRESS** Direct all correspondence to: Place Customer Number Customer Number Bar Code Label here Type Customer Number here OR University of South Carolina Firm or Individual Name Osborne Administration Building Address Room 109 Address SC 29208 Columbia City ZIP State USA Telephone | 803-777-7854 803-777-9500 Country ENCLOSED APPLICATION PARTS (check all that apply) ✓ Specification Number of Pages 56 CD(s), Number Drawing(s) Number of Sheets Other (specify) Application Data Sheet. See 37 CFR 1.76 METHOD OF PAYMENT OF FILING FEES FOR THIS PROVISIONAL APPLICATION FOR PATENT **FILING FEE** Applicant claims small entity status. See 37 CFR 1.27. AMOUNT (\$) A check or money order is enclosed to cover the filing fees The Commissioner is hereby authorized to charge filing \$80.00 fees or credit any overpayment to Deposit Account Number: Payment by credit card. Form PTO-2038 is attached. The invention was made by an agency of the United States Government or under a contract with an agency of the United States Government. Yes, the name of the U.S. Government agency and the Government contract number are: Respectfully submitted 12/31/2003 Date **SIGNATURE** REGISTRATION NO. TYPED or PRINTED NAME Michael L. Myrick

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419-PPA

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Provisional Patent Application

Michael L. Myrick, Paul G. Miney, and Maria V. Schiza University of South Carolina

Thin-layer Porous Optical Interferometric Sensors for Gases and Other Fluids

We claim the invention having the embodiments described herein.

Abstract

Non-Enabling Abstract

A new type of gas sensor has been designed, constructed and characterized. This sensor uses optical interferents in a porous thin film cell to measure the refractive index of the pore medium. As the medium within the pores changes, spectral variations can be detected. For example, as the pores are filled with a solution, the characteristic peaks exhibit a spectral shift in one direction. Conversely, when tiny amounts of gas are produced, the peaks shift in the opposite direction. This can be used to measure gas evolution, humidity and has potential applications for other interferometric-based sensing devices.

Full Paper

A New Optically Reflective Thin Layer Electrode (ORTLE) Window: Gold on a Thin Porous Alumina Film Used to Observe the Onset of Water Reduction

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Abstract

The fabrication and unique characteristics of a new type of thin layer electrode. An optically reflective thin layer electrode (ORTLE), are described. The electrode was fabricated by the anotization of a thin layer of aluminum sputtered onto a plain glass microscope slide to create a 750 nm-thick porous alumina film. At thin film of gold was then sputtered atop the porous and transparent alumina film. The gold layer remained porous to allow solution into the pores but was optically thick and reflective. Reflectance measurements made through the microscope slide did not interrogate the bulk solution, but show spectral features that shift with the optical properties of the material filling the pores of the alumina film. A simple series of experiments, in which the optical properties of the material filling the negatively to various values in an aqueous sodium sulfate solution, shows that interference fringes shift measurably in the ORTLE spectrum at potentials several hundred millivolts positive of the potential at which gas evolution was visible to the naked eye.

Keywords: OTTLE, Porous alumina, Spectroelectrochemistry, Specular reflectance spectrosco

1. Introduction

Spectroelectrochemistry is a combination of electrochemical and spectroscopic techniques in which optical measurements are referred to the potential of a working electrode. Thin-layer spectroelectrochemistry is possibly the simplest type of spectroelectrochemistry and has advantages such as rapid and exhaustive electrolysis and small volume features [1]. Since the first report in 1967 [2] coptically transparent thin layer electrodes (OTRES) have been used for such thin layer studies [3-5]. A typical application of an OTTLE is the spectroscopic study of medox processes [6-8]. Various spectroscopic techniques such as illuminescence spectroscopy [9] and UV/vis/NIR [10-12] have been coupled with electrochemical techniques via OTTLEs and ta variety of OTTLE designs for many purposes have been developed [13-15].

As a consequence of our work with nanoelectrode arrays [16, 17] we have carried out studies into the anodization of

As a consequence of our work with nanoelectrode arrays [16, 17] we have carried out studies into the anodization of aluminum thin films on various substrates. We recently reported a study of the anodization of aluminum thin films sputtered onto an electrically insulating substrate – a plain float glass microscope slide [18]. The resulting porous aluminum oxide (alumina) films are transparent and contain pores varying from approximately 80 to 100 nm in diameter. In this article, we describe the design and characterization of a new type of thin layer electrode which is a variation on the concept of an OTTLE. The essential difference between an OTTLE and our new electrode is that reflectance is

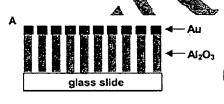
collected instead of transmittance. For this reason, the electrode is called an optically reflective thin layer electrode (ORTLE) in the following discussion. This new electrode is based on the porous alumina thin films in [18]. In the case of the ORTEE spectroscopy interrogates a solution phase within the pores of the alumina film between the electrode face and a window behind it. The electrode is created by thin-film deposition of gold onto the exposed face of the porous alumina, creating a gold electrode filled with holes having a diameter much less than the wavelength of visible flight. The thickness of the alumina film – and thus the depth of the pores - can be altered by controlling the thickness of the original aluminum film. Through the use of a combination of specular reflectance spectroscopy and chronoamperometry, we can confine our spectroelectrochemical study to that solution contained within the pores. The ORTLE described here interrogates the thinnest sample of which the authors are aware and is the first based on porous alumina. In this report, we describe the preparation of the ORTLE in detail, plus how the ORTLE is incorporated into spectroscopic measurements. We also characterize the stability of the ORTLE spectrum and its origin, and show how an applied potential affects the observed spectrum in a simple solution.

2. Experimental

2.1. ORTLE Design and Concept

The design of the ORTLE is shown in Figure 1A. A 500 nm aluminum film was sputtered onto a plain float glass slide $(75 \times 25 \times 0.5 \text{ mm})$, anodized and subsequently converted to porous alumina as described previously [18, 19]. The resulting 750 nm thick transparent alumina film was subsequently coated for 210 s with gold using a CRC-100 sputtering system (Plasma Sciences Inc., Lorton, VA), producing a gold film approximately 100 nm thick. Although this appears to be an optically thick gold film, scanning electron microscopy (SEM) studies in our laboratory have shown this is insufficient to seal the somewhat larger pores of a commercial porous alumina membrane [16, 17]. The SEM image in Figure 1B shows that the pores of the alumina films created by the process in [18] also remain open when coated with gold in this way.

The gold film possesses a mirror finish on its "face", the exposed side opposite the porous alumina. Despite this and the apparent continuity of the film, it is highly porous and allows the filling of the channels in the underlying alumina when exposed to solution. The reverse side of the gold film, however, does not show this highly reflective finish, although it presents a mostly specular surface. Light can pass through the optically transparent glass slide used a support and through the fluid-filled alumina, but is reflected by the porous metal overlayer. When a potential is applied to the gold film, any solution changes that occur within the pores can be monitored by specular reflectance spectroscopy. Note that the ORTLE design requires no spe auxiliary or reference electrodes and no special electrode configurations. In our spectroelectrochemical cell design we use it as a window into a bulk solution, since only the solution in the alumina pores is interrogated



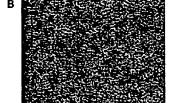


Fig. 1. A) Schematic of the side profile of the ORTLE and (B) SEM image of the porous alumina covered with the layer of gold showing that the pores are not sealed.

2.2. Spectroelectrochemical Cell Design and Set-Up

The ORTLE was mounted in a home built spectroelectrochemical cell (see Figure 2). The cell was constructed from Teflon and contained a rectangular window (75 × 25 × 0.5 mm) to which the thin layer electrode could be attached. The ORTLE was positioned with the gold sputtered side facing inwards and was held in place by 8 screws, which could be tightened to avoid any leaking of the solution. The ORTLE subsequently acted as the working electrode in the spectroelectrochemical cell. The cell was then mounted on an aluminum base, which could be placed inside the spectrometer. The height of this aluminum base was designed to place the ORTLE in the path of the incident light beam. When the ORTLE was attached, the spectroelectrochemical cell could from be filled with the desired solution, into which the auxiliary electrode (PT gauze) and reference electrode (Ag/AgClsat NaCl, BAS, West LaFayette, IN) could be inserted.

ette, IN) couldibe inserted.

The home built spectroelectrochemical cell was placed inside a goniospectroreflectance attachment (750-75 MA, Optronic Laboratories Inc., Orlando, FL) as shown in the schematicotral gure 3. It was then illuminated by a tungsten quartz-halogen lamp (150 W) and monochromator (750 M-S, Optronic Laboratories Inc.) combination that selected

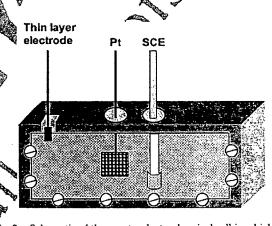


Fig. 2. Schematic of the spectroelectrochemical cell in which the ORTLE is mounted.

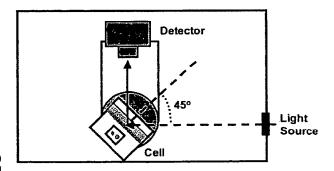


Fig. 3. Schematic of the cell in the spectroelectrochemical set-up.

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wavelengths in the range of 280-1100 nm. A silicon detector (DH-300EC, OL750-HSD-301EC, Optronic Laboratories Inc.) was used to record the reflected intensity. The spectra were obtained by the Optronic Laboratories software and further analyzed using IGOR Pro (Version 4.01, Wavemetrics, Inc.).

All electrochemical experiments were carried out using an EG&G PARC Model 263 potentiostat, connected with a general purpose interface bus (GPIB) (National Instruments, Atlanta, GA) to a Gateway 2000 Model P5-60 computer with EG&G Model 270 Research Electrochemistry Powersuite Software. Gold wire electrodes were purchased from CH Instruments, Austin, TX. Potassium ferricyanide (Mallinckrodt, Hazelwood, MO) and sodium sulfate (Fisher Scientific, Suwanee, GA) were all reagent grade and were used without further purification. All solutions were prepared with deionized water. SEM images were collected using a Quanta 200 scanning electron microscope (FEI Company, Hillsboro, OR).

3. Results and Discussion

3.1. Characterization of the ORTLE

Figure 4 shows how the ORTLE functions as a typical working electrode. In this figure, a comparison is made between a cyclic voltammogram (CV) obtained at a conventional gold wire electrode (A) and one obtained using the ORTLE as a working electrode (B). Both experiments were carried out in 0.01 M ferricyanide/0.05 M sodium sulfate solutions at 20 mV s⁻¹. As can be seen in Figure 1 the ORTLE behaves similarly to the wire electrode. The purely electrochemical characteristics of the ORTLE electrode reflect those of bulk solution conditions because othe electrode is immersed in bulk solution. What is important to take from this experiment is the ability of the ORTLE to exhibit the standard characteristics that would be expected in a ferricyanide solution given that the design of the electrode is such that a very thingold layer is sputtered on a porous alumina film and does not seal the pores.

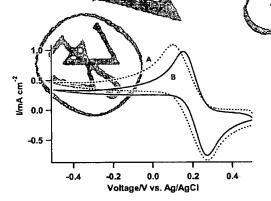


Fig. 4. CVs, carried out at 20 mV s⁻¹ in a 0.01 M potassium ferricyanide/0.05 M sodium sulfate solution, obtained for a standard gold electrode (A) and the ORTLE (B).

A decrease in the separation of the peaks was observed for the ORTLE, which would be expected for a contribution from restricted diffusion occurring within the pores. To test this, an experiment was conducted to measure the effect of sweep rate (ν) on the peak current. For a thin layer cell, the peak current should be directly proportional to ν [13, 20]. This study revealed a poor relationship between peak current and ν and an excellent relationship between peak current and $\nu^{1/2}$ ($R^2 = 0.999$). This result indicates that, for this CV, the contribution of thin layer electrochemistry is negligible compared to that of the bulk solution.

Figure 5 shows transmittance spectra of a plain float glass microscope slide (A), of a similar glass slide with a layer of porous alumina (B), and of an ORFLE (C), all taken at a 45° angle to the incident beam dinterference effects in the spectrum (B) are the result of the refractive index contrast between glass and the overlying films, while the reduced overall transmittance is due to the absorbance of residual aluminum in the film and scattering in the film. The transmittance of the ORTLE is negligible on the scale of Figure 5 due to the presence of the reflective gold film and thus little interrogation of the bulk solution can occur through the film. Spectroscopic changes based on specular reflectance on the backside of the gold film must therefore be ascribed to either changes in the medium within the pores or changes in the electrode itself.

Figure 6 shows a typical specular reflectance spectrum (solid black line) obtained for the ORTLE without any solutions in the cell. The specular reflectance measurements were performed by positioning the cell at 45° to the incident beam, and the detector at 90° to the specular reflected beam (see Figure 3). Single beam reflectance measurements were referenced to the total intensity of the source by directing 100% of the incident beam to the detector before each experiment. Several small interference peaks can be observed at shorter wavelengths with a relatively large peak usually observed within the range of approximately 700 – 1000 nm (the wavelengths and the appearance of the peaks varied from ORTLE to ORTLE due to slight differences in the thickness of the original aluminum films). Upon the introduction of a sodium sulfate solution, the peaks shifted

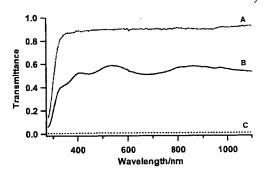


Fig. 5. Transmission spectra for a glass slide (A), a glass slide coated with an alumina layer (B) and the ORTLE (C).

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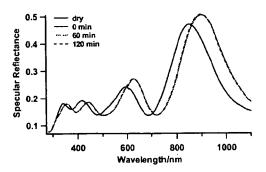


Fig. 6. Specular reflectance spectra showing the red shift observed after the introduction of a 0.05 M sodium sulfate solution, and monitoring the changes in the spectra over time.

towards longer wavelengths, accompanied by an increase in intensity – for this sample the large peak shifted from 850 to 900 nm, as indicated by the spectrum collected after 0 min (i.e., it was collected immediately after the introduction of the sodium sulfate solution). The spectra collected after 60 min and 120 min show, that for this ORTLE, no further red shifts or increases in intensity were observed. While this particular ORTLE responded promptly, some ORTLEs showed a gradual red shift over time after solution was introduced. In all cases, less than 1 hour was necessary for this change to be completed. At least part of this change is likely the result of pores being filled with solution and changing the effective refractive index of the porousfilm, as the shift is consistent with changes in interference fringe positions expected in that case within a factor of two

Referring to Figure 7, one condition for the appearance of strong interference-based oscillations in the reflections spectrum of the ORTLE is that the reflectivity of the glass/alumina and alumina/gold interfaces are of comparable magnitudes. This is achieved only because the electrochemical synthesis of the porous alumina film leaves a small amount of aluminum metal behind at the glass/alumina interface, approximately 12 nm thickness on average as indicated by ellipsometry [18]. Aluminum is the most

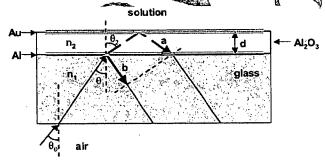


Fig. 7. Schematic of the optical pathlengths (a and b) of incident light from air through the glass substrate (refractive index = n_1) and alumina layer (refractive index = n_2 and thickness = d) with two reflective interfaces resulting from unanodized aluminum and the gold coating.

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opaque metal in the visible region. According to optical modeling of this electrode, too much aluminum at the interface (e.g., 50 nm) would cause the spectrum of the ORTLE to be that of an aluminum mirror. Too little aluminum at the interface would produce a spectrum like that of a gold mirror with small (e.g., 5%) interference oscillations in the blue and UV, dropping to about 1% oscillation in the red and NIR.

With this first condition met, constructive interference in reflection occurs when the difference in the optical pathlengths a and b are an integral number of wavelengths of incident light. Assuming an isotropic material with no absorbance, the optical pathlength is the physical pathlength multiplied by the (real) refractive index of the medium. Making use of Snell'staw:

$$\sin(\theta_0) = n_1 \sin(\theta_1) = n_2 \sin(\theta_2) \tag{1}$$

where θ_0 is the angle of the incident light from air to the glass, θ_1 is the angle that the beamenters the porous alumina layer from the glass, substrate θ_2 is the angle of the beam that interacts with the gold layer and n_1 and n_2 are the refractive indices of the glass and porous alumina layers, respectively.

It is possible to show that the optical path difference OPD is:

$$ORD = 2d\sqrt{n_2^2 - \sin^2(\theta_0)} = m\lambda_{\text{max}}$$
 (2)

where *m* is a non-negative integer, *d* is the film thickness and have is the maximum wavelength. The apparent refractive index of the film, *n*₂, is approximately related to the volumetric composition of the films, assuming the film structure to be heterogeneous on a scale less than the wavelength of light and with no regular repeating patterns. For the dryfilm,

$$n_2 \approx n_{Al_2O_3} (1 - f_p) + f_p \tag{3}$$

Where $n_{Al_2O_3}$ is the refractive index of alumina, f_p is the pore fraction of the porous alumina and the refractive index of air is taken to be 1. As the pores of the alumina film fill with solution Equation 3 becomes:

$$n_2 \approx n_{Ab,O_1}(1 - f_p) + 1.33f_p$$
 (4)

where the refractive index of the filling solution is assumed to be that of water. For any value of m,

$$\frac{\lambda_{\max dry}}{\lambda_{\max wet}} = \frac{\sqrt{n_{2,dry}^2 - \sin^2(\theta_0)}}{\sqrt{n_{2,wet}^2 - \sin^2(\theta_0)}}$$
(5)

Since the refractive index of the solution filled film is always greater than that of the dry film, the filling of the pores will always result in a red shift.

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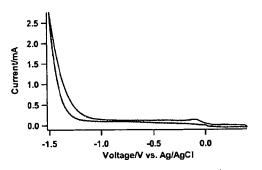


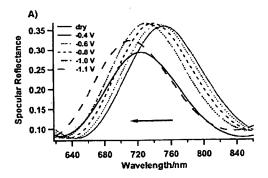
Fig. 8. CV obtained for an ORTLE, carried out at 5 mV s⁻¹ in a 0.05 M sodium sulfate solution, showing the background limit of the solution.

3.2. Reduction of Water

In the remainder of this manuscript, we report observations made by specular reflectance spectroscopy on the ORTLE as a function of potential in a simple solution of 0.05 M Na₂ SO₄. For these experiments, the auxiliary and reference electrodes were inserted into the spectroelectrochemical cell and the three electrodes were connected to a potentiostat. Figure 8 shows a CV for the Na₂SO₄ solution where the potential was swept from +0.4 V to -1.5 V vs. (Ag/AgCl). The positive potential limit observed for the ORTLE was apparently due to gold oxide formation. More positive potentials resulted in delamination of the fragile gold film from the porous alumina substrate, a common indicator of stress at the film/substrate interface. The negative potential limit of the ORTLE was not due to delamination but apparently to dissolution of the porous alumina by hydron ide ions generated during hydrogen evolution. The cathodic current associated with hydrogen evolution can be seen to begin at approximately – 1.1 V (vs. Ag/AgCl) in Figure 8.

The ORTLE for which results are described in Figure 9 show a "dry" reflectance spectrum in which one of the observed peaks was centered at \$12.5 nm. The addition of the sodium sulfate solution to the spectroelectrochemical cell-caused this peak to shift to \$755.nm. Reflectance spectra were acquired during the 400 s that the potential was held at a certain value for steps to potentials between +0.1 V and -1.2 V (vs. Ag/AgCl). Figure 9A shows detail in the reflectance spectrum of this ORTLE at a subset of these potentials, between 0.4 V and -1.1 V (vs. Ag/AgCl), with the "dry" spectrum for reference.

No significant changes were observed in the ORTLE reflectance spectra at potentials positive of -0.5 V (vs. Ag/AgCl). When the potential was stepped to -0.5 V (vs. Ag/AgCl), however, a blue shift of the peaks was observed. As Figure 9A shows, the interference peak at 755 nm continued to shift toward the blue very gradually with increasing negative potential until -1.0 V. A decrease in intensity was not observed over this potential range; in fact, a slight increase in intensity was observed. When the potential was stepped to -1.1 V, however, a more pronounced blue shift of the large peak at 755 nm was observed that was



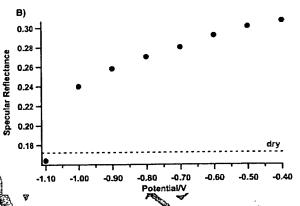


Fig. 9. A) Effect of potential on the specular reflectance spectrum concentrating on the peak at approximately 755 nm and (B) decrease in magnitude of the reflectance at 780 nm with increasing negative potential. The dashed line indicates the dry state of the ORTLE at 780 nm.

accompanied by a substantial decrease in intensity. This is interpreted as the result of gas infiltrating the pores of the alumina. Spectra obtained at more negative potentials showed weaker and broader interference peaks that did not recover when the electrode was returned to more positive potentials. This is interpreted as a result of the concomitant generation of hydroxide during hydrogen evolution; hydroxide is known to dissolve the porous alumina film and could cause collapse of the ORTLE structure. Further experiments are under way at present to test this hypothesis by controlling the pH with a buffer solution.

In electrochemical experiments carried out with ORTLEs outside of the spectrometer, it was not possible to see hydrogen evolution with the naked eye until the potential approached -1.5 V. The increase in current observed in Figure 8 near -1.1 V is, however, attributable to the onset of water reduction. The low level of hydrogen production occurring at -1.1 V was insufficient to form bubbles large enough to be observed by the naked eye, but sufficient to strongly perturb the ORTLE specular reflectance. Assuming pores to be filled initially with water and that this water is displaced by gaseous hydrogen generated at the electrode, the apparent refractive index of the film can be written as:

$$n_2 \approx n_{Al_2O_3} (1 - f_p) + 1.33 f_p - RT n_{H_2} / (3dA)$$
 (6)

where n_{H_2} is the number of moles of H_2 produced, A is the area of the electrode, R is the ideal gas constant, and T is the absolute temperature.

Inserting this definition into equation 2, solving for wavelength and taking the derivative with respect to the number of moles of H₂ produced under initial conditions of pores filled with only water or a water-like electrolyte, we obtain:

$$\lambda_{\max} = \frac{2d\sqrt{(n_{\text{Al}_2\text{O}_3} - f_p(n_{\text{Al}_2\text{O}_3} - 1.33))^2 - \sin^2(\theta_0)}}{\text{m}}$$

$$\frac{\partial \lambda_{\max}}{\partial n_{H_2}} = -\frac{2RT(n_{\text{Al}_2\text{O}_3} - f_p(n_{\text{Al}_2\text{O}_3} - 1.33))}{3mA\sqrt{(n_{\text{Al}_2\text{O}_3} - f_p(n_{\text{Al}_2\text{O}_3} - 1.33))^2 - \sin^2(\theta_0)}}$$
(7)

Inserting a void fraction of 0.32 (estimated from ellipsometry [18]), a film thickness d of 680 nm (estimated from modeling of the film in Figure 6), and an incident angle of 45 degrees, the maxima should occur at:

$$\lambda_{\text{max}} \approx 1851 \text{ nm/}m$$
 (8)

From Equation 5, it is evident that m=2 for the long within the pores of the ORTLE. wavelength peak in Figure 6, and is 3, 4 and 5 for the peaks at progressively shorter wavelengths. Returning to Equation the sensitivity of the peak position of the m = 2 peaks hydrogen is:

$$\frac{\partial \lambda_{max}}{\partial n_{H_2}} = -\frac{9 \times 10^{10} nm \, mol^{-1} \, cm^2}{A}$$

a 9 nanometer hypsochromic shift in the m=2 peak. If we assume that a 1 nm shift could be detected and we imagine our sensor on the end of a fiber-optic with an area of 10^{-4} cm². , approximately I fM of H2, evolution could be detected if the

gas were captured in the pores of the alumina.

Subtle shifts in the wavelength of the interference peak maximum in Figure A were observed at potentials as positive as 0.5 V (vs. Ag/AgCI). The origin of this shift is unknown at present, but must involve changes in the composition of the porous film or of the solution in the pore volume. The blue shift indicates an overall decrease in the optical thickness of the film under these conditions, an effect that is consistent with displacement of pore solution by nanoscale bubbles. In Figure 9B, the variation in the magnitude of the reflectance at 780 nm is plotted against potential. As can be seen in this figure the intensity follows a similar trend with varying potential, in that a large increase of intensity is observed upon the addition of solution and a gradual decrease observed with increasing negative potential. Eventually, at -1.1 V Figure 9B shows that the intensity is similar to that of the electrode in the dry state.

4. Conclusions

A new type of thin layer electrode, based on a gold-coated porous alumina film, has been designed and fabricated. The cell was characterized by cyclic voltammetry and spectroscopic techniques and by spectroelectrochemistry, where a combination of specular reflectance spectroscopy and chronoamperometry was used. Typical spectra exhibited several strong interference peaks which resulted from the presence of a small amount of unanchized aluminum at the glass/porous alumina interface. A red shift of the peaks in the specular reflectance spectrum and an increase in intensity was observed upon the introduction of a sodium sulfate solution to the spectroelectrochemical cell where the ORTLE was mounted. We believe that this was due to refractive index changes arising from the filling of the pores by the solution. A blue shift of the peaks could be induced by stepping the potential to values increasingly negative of -0.5 V (vs. Ag/AgCl) and towards the background limit of the solution. Upon stepping to 11 V, a pronounced blue shift was observed, accompanied by a decrease in intensity. We believe that this is due to the production of hydrogen

Finally, this new electrode differs from typical thin-layer electrodes in several ways. First, no transparent electrodes are required, and the solution does not have to be transparent or even homogeneous, because the nanostructured electrode face filters out particles large enough to cause significant scattering. The electrode can thus be used in bulk solutions as a window that does not allow light into the bulk - similar to total internal reflection techniques, but with no critical angle constraints. Further, the electrode can poten-Equation 6 indicates that 0.1 nanomole of H₂ produced per tially be designed to combine refractive-index measure-centimeter squared area of electrode surface could result in ments with surface plasmon resonance and UV-visible tially be designed to combine refractive-index measureabsorbance measurements with very minor changes.

5. Acknowledgements

The authors gratefully acknowledge the USC NanoCenter and the Petroleum Research Fund (ACS PRF# 36477-AC5) for support of this research.

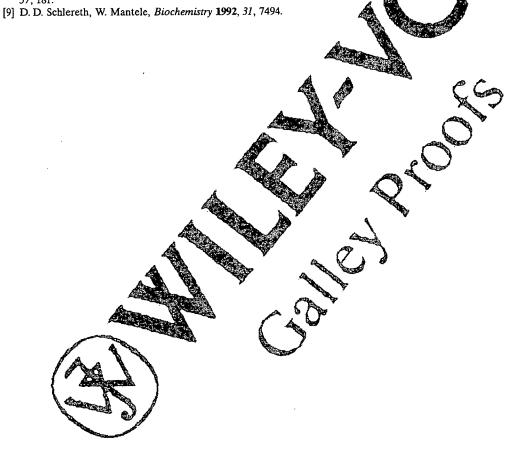
This effort was also sponsored by the Human Effectiveness Directorate, Air Force Research Laboratory, Air Force Materiel Command, USAF, under grant number F33615-00-2-6059. The U.S. Government is authorized to reproduce and distribute reprints for Governmental purposes notwithstanding any copyright notation thereon. The views and conclusions contained herein are those of the authors and should not be interpreted as necessarily representing the official policies or endorsements, either expressed or implied, of the AFRL Human Effectiveness Directorate or the U.S. Government.

We would like to thank Mr. Allen Frye for building the spectroelectrochemical cell.

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July 2002 - Sept 2003



56-907 MADE IN U. S. A

Going to place ob oscied state horizontally into cell. Grove to GE PE South Thanks state the state of the st	Design of tell	1003 Ex elatrografysis papa
Consider the state of the state	00	D.C.
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	June 16: 2003.
B. L.	(arried out ents first spectroelectrochemistry expts with the
	Used 0 03M Was 504 as the solution was not de-aerated as had to insert the solution into the cell with a pipette!
	Used AglAge retevence electrode as the RE and the Pt gauge
· · · · · · · · · · · · · · · · · · ·	The working electroide was the gold wated, alumina wated glass slide.
	Cell takes about 50-55 mls to fill it
	Carried out specular reflectance expts before and after insertion of the solution into the cell. Usual red-shift observed
,	Corried out a few CV expts to see it the set-up actually
	5561603a 0.4V > -0.N > 0.4V e 10.15 Vorted well a little noisy but not bad at all.
	55 61603b 0.4V 3 -0.3V 3 70.4V Q 1017

Than, a good, smooth CV. Stopped at -0.3x 45 cui rose rapidly - did not last excessive hydrogen evolution result in destruction a delamination of the gold film. Nos trying to find exactly were hydrogen evolution collections are ted. Did not work to go too negative Idea was to see if the evolution at -ve potentials could to proceed up by the specular reflectance technique. Unat should be expected is a blue shift of the spectrum to show lawards a peaks were observed prior to insertion of solution. This is as a result of the generation of air like situation within Expts were corried out like this! Maria's specific reflectance experiments lasted approx 5mm 3350 I set of the potential step expts for 400 s Uhan to intend thereign spike has observed. Maria started the spouling reflectance expt. Always stepped from 0.1V as the Wexprevealed that no wrint was evident at this potential. 616 step 81 0 1 > 0 V 616 step 12 0 iv 3 -0.05V

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	1d good (V drained - not much noise) 1V 3 -0.40 P 10/3
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· f	→ -0.9V

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and should had a	do a hune difference to the spectra in
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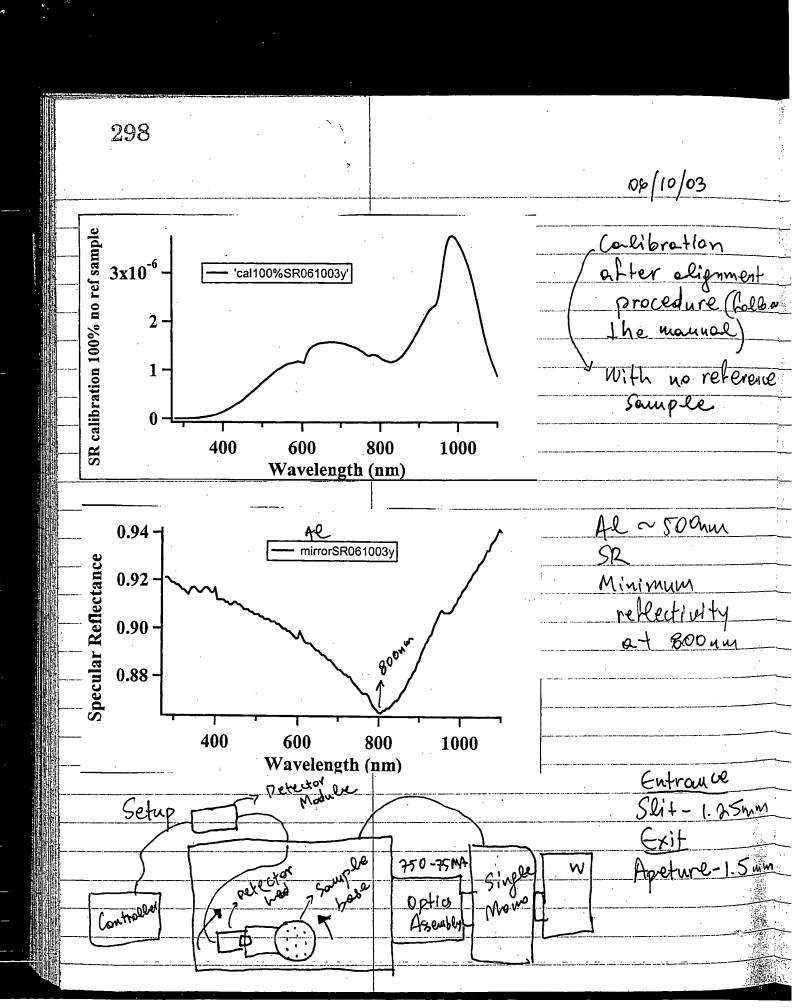
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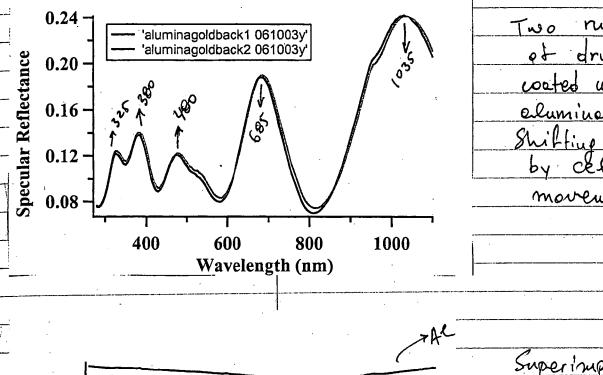


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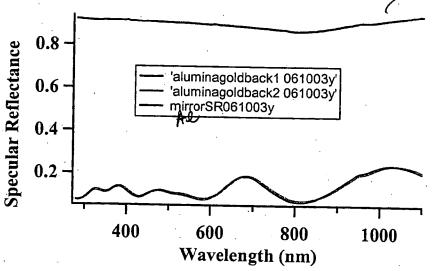
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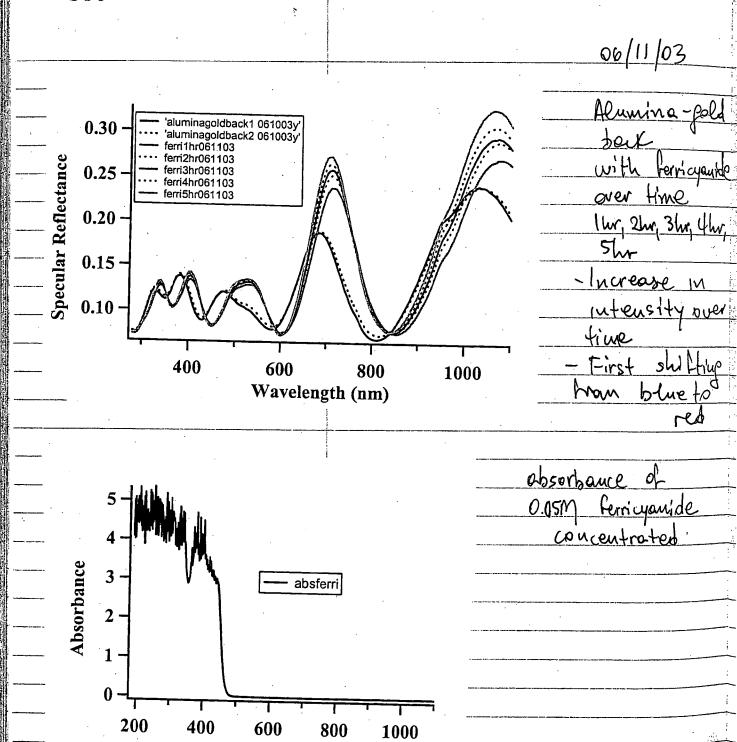




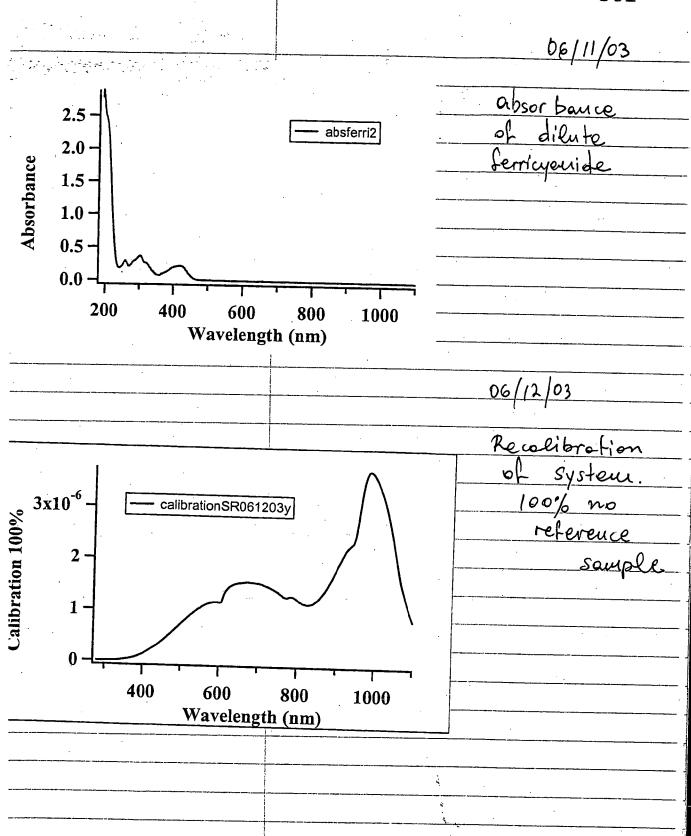


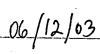
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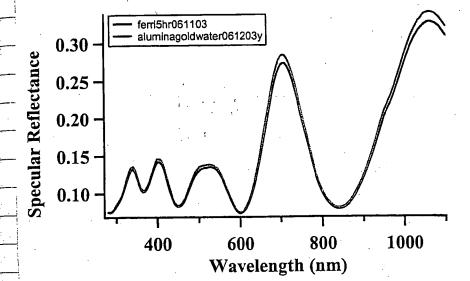




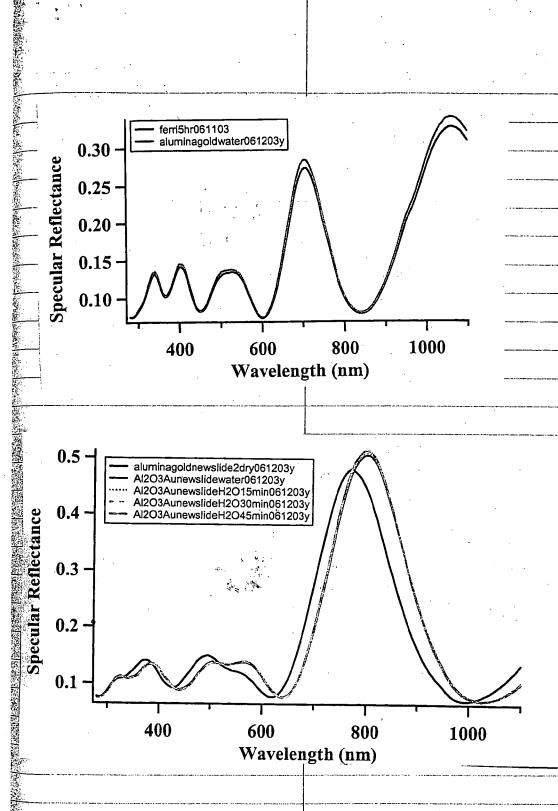
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MARIA V. SCHIZA Postdoctoral Fellow Department of Chemistry and Biochemistry



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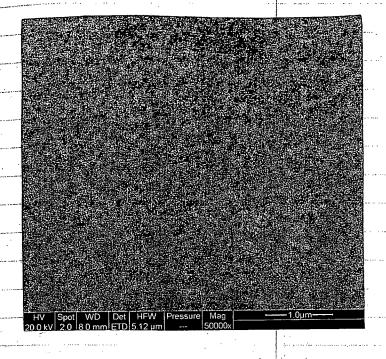
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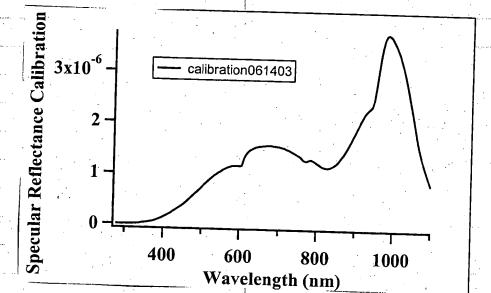
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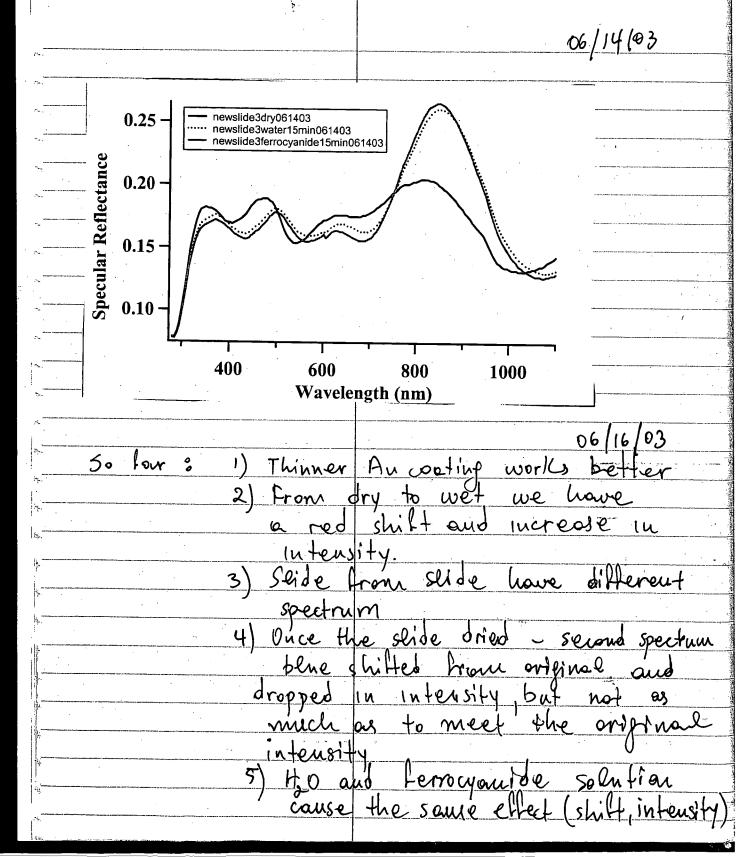


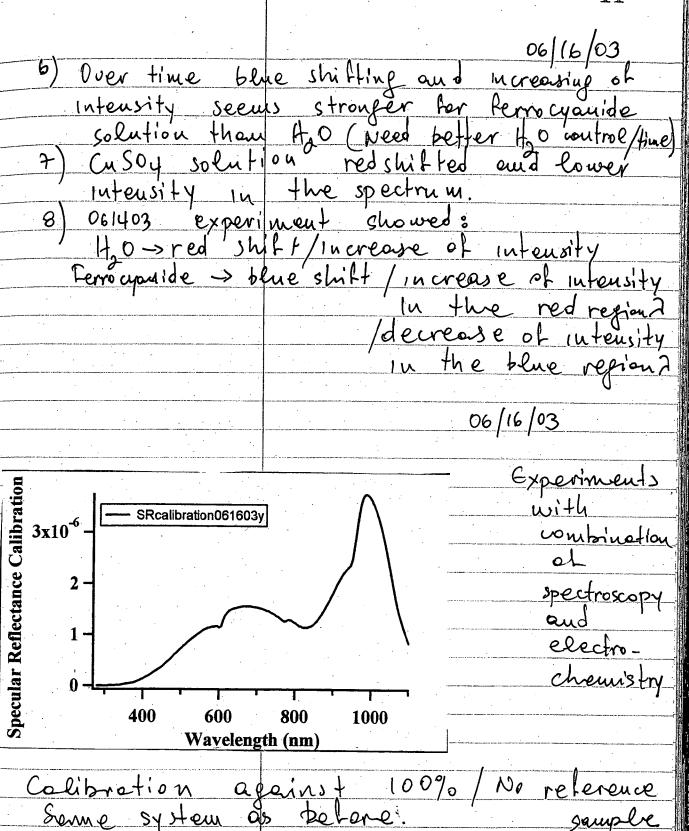
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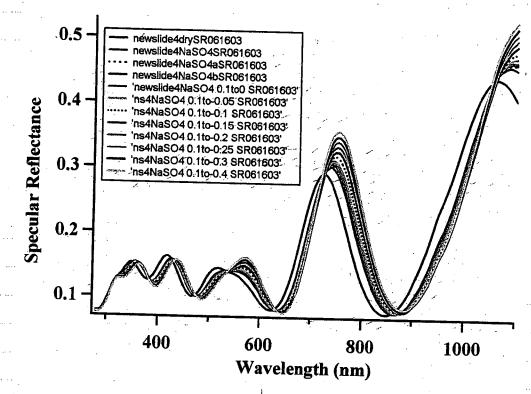
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From dry alumine / fold (3.5 min) thinner (SEM)

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literateody potential. We see red shifting and

Increase of Intensity at 725 nm and 1060 nm.

Red shifting and increase of intensity at 520 nm.

Also observe the isosbestic point and increase
of a different peak at 570 nm.

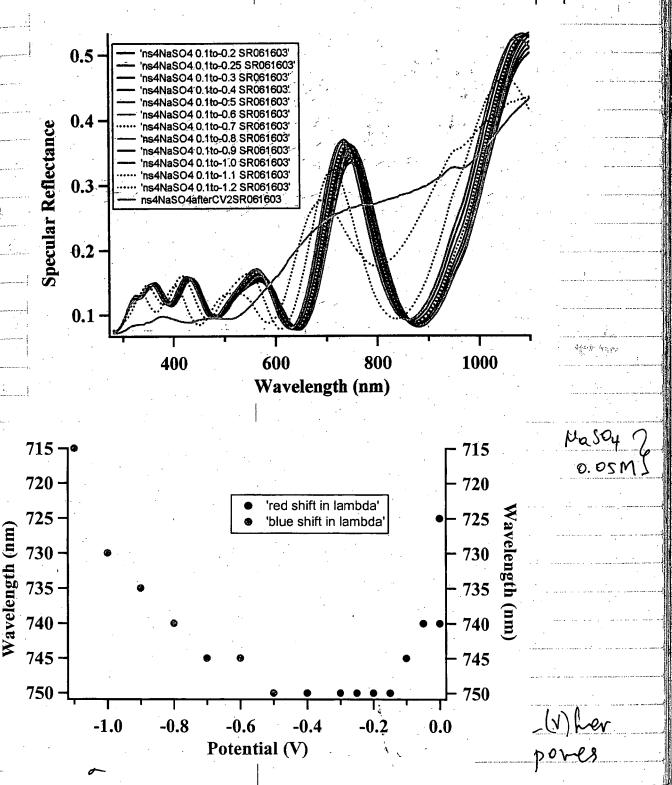
Peaks at 350 mm and 420 nm show red

Shifting but no increase, rather a slight

decrease of intensity.

Peak at 320 nm does not chause.

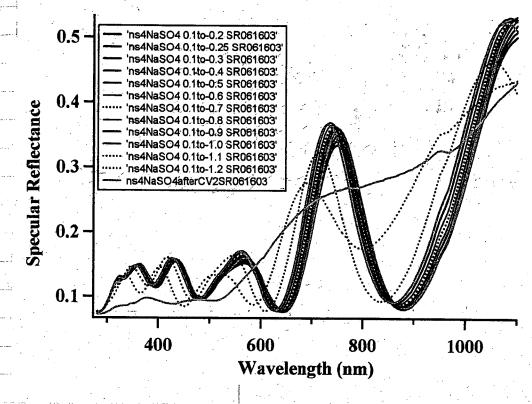
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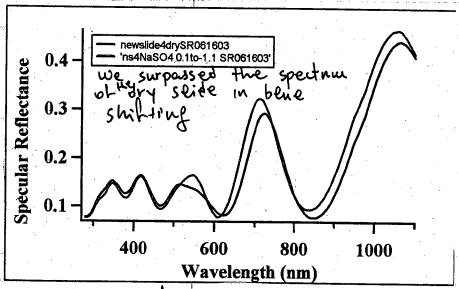


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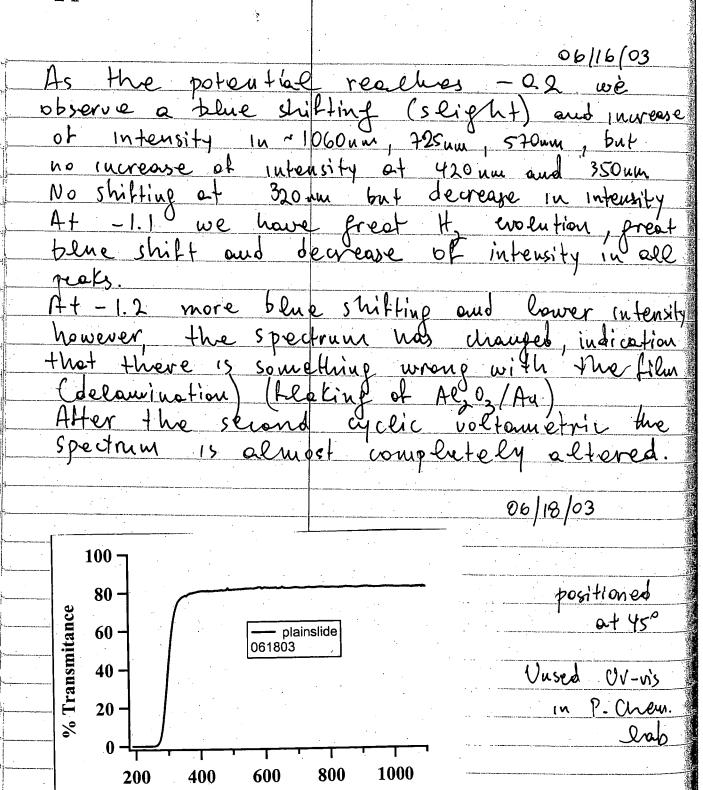
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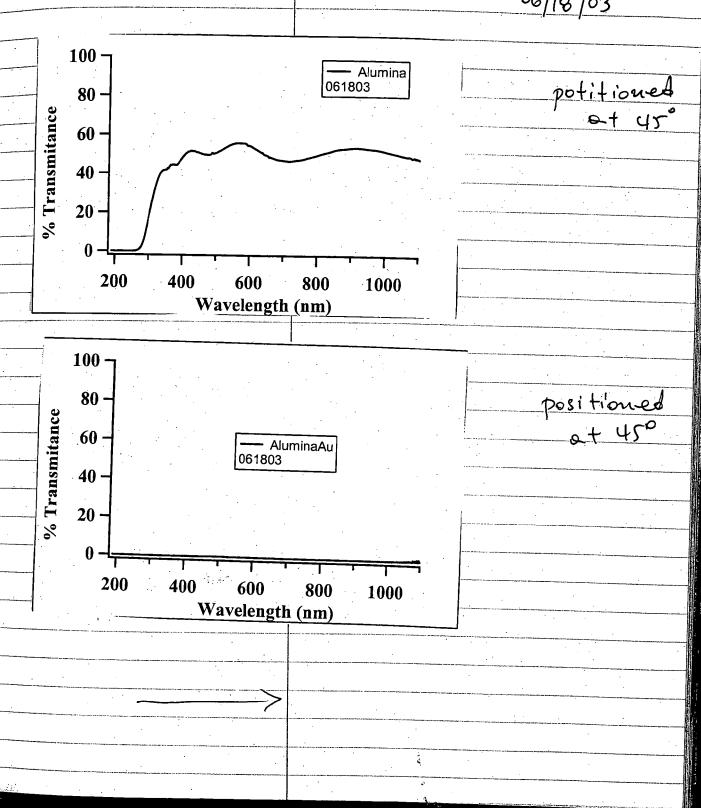


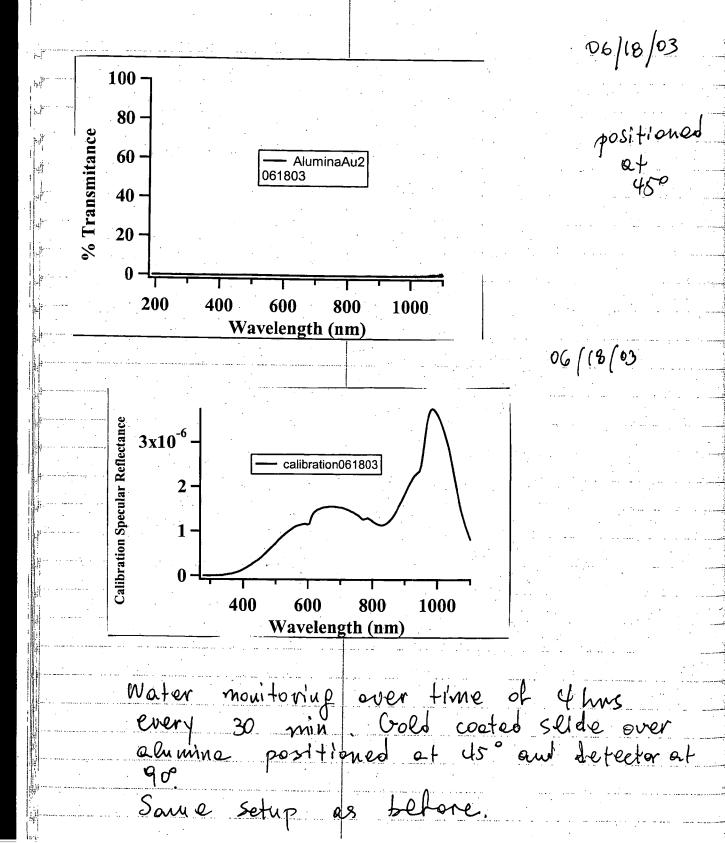
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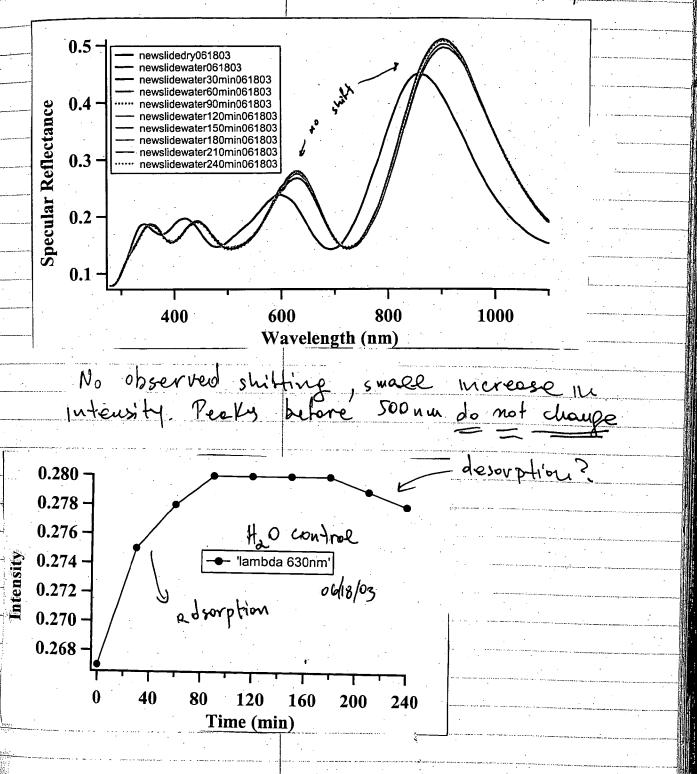
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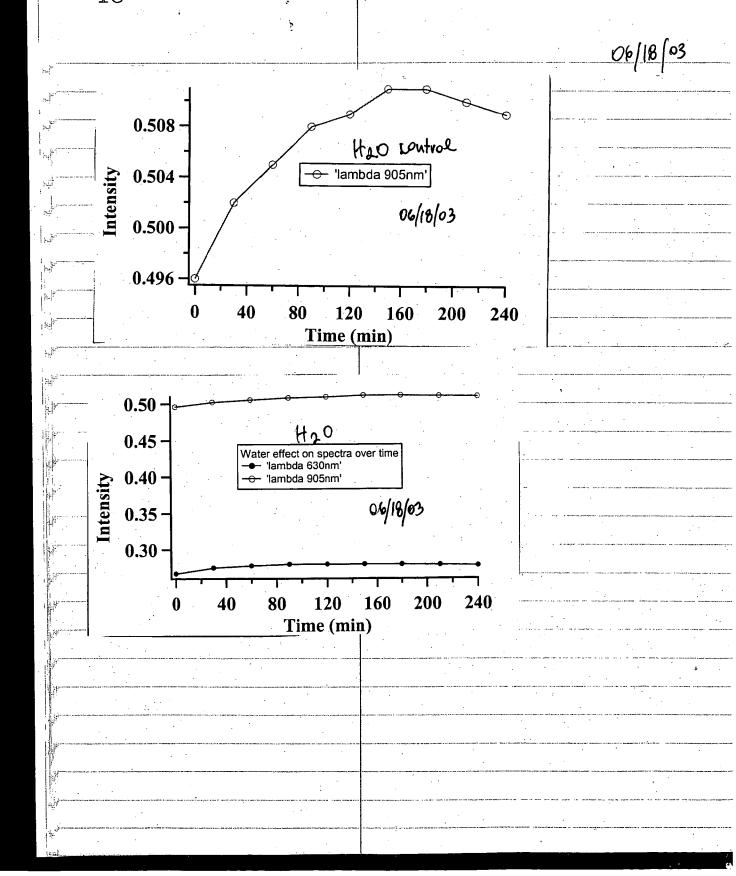
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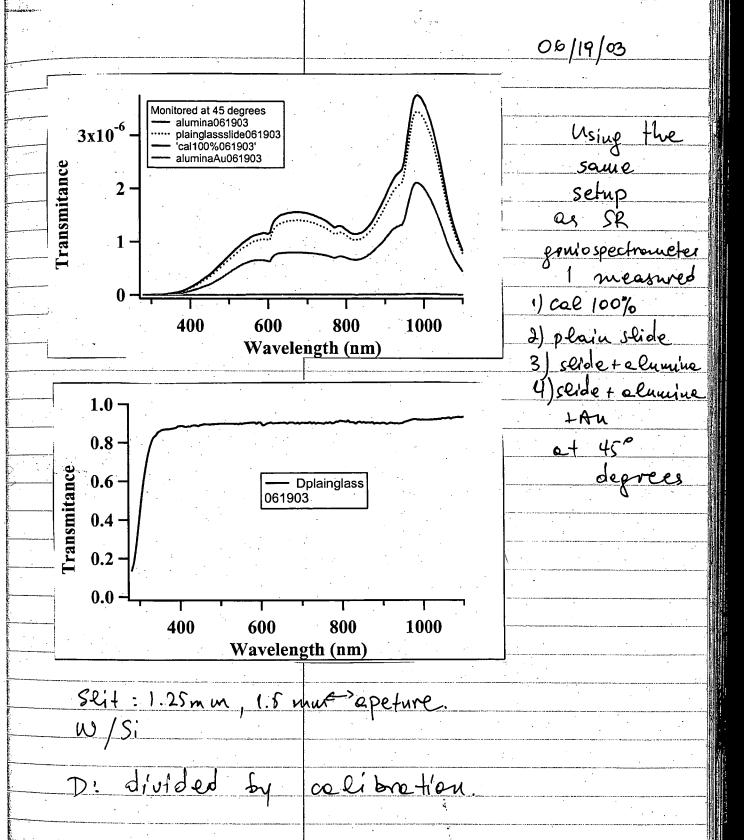




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1.0

0.8

0.6 -

0.4

0.2

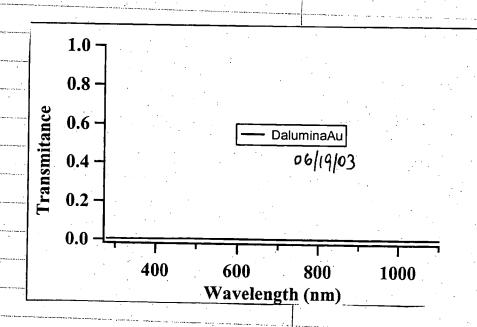
0.0

400

Transmitance







600

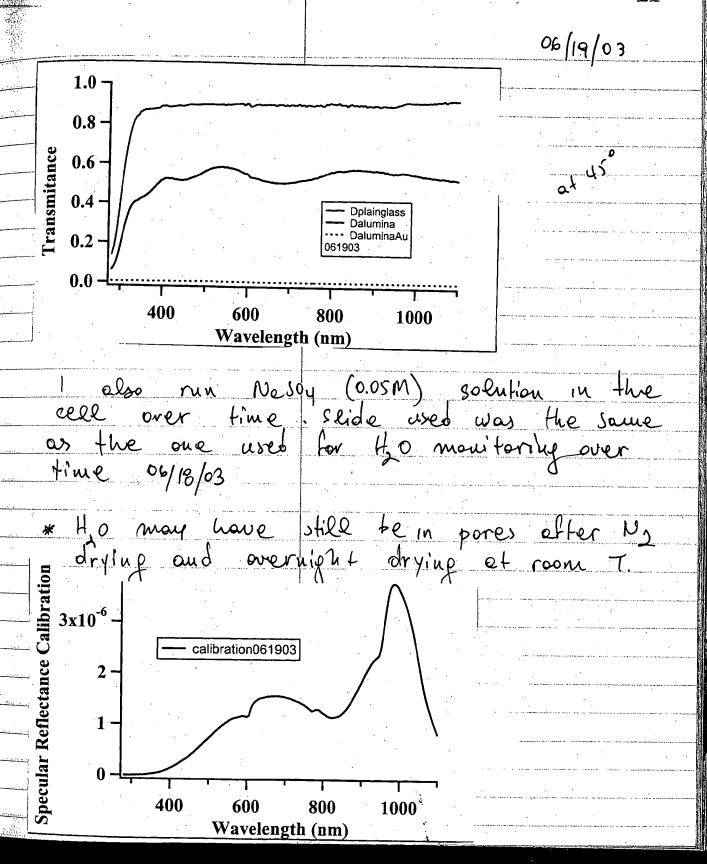
Wavelength (nm)

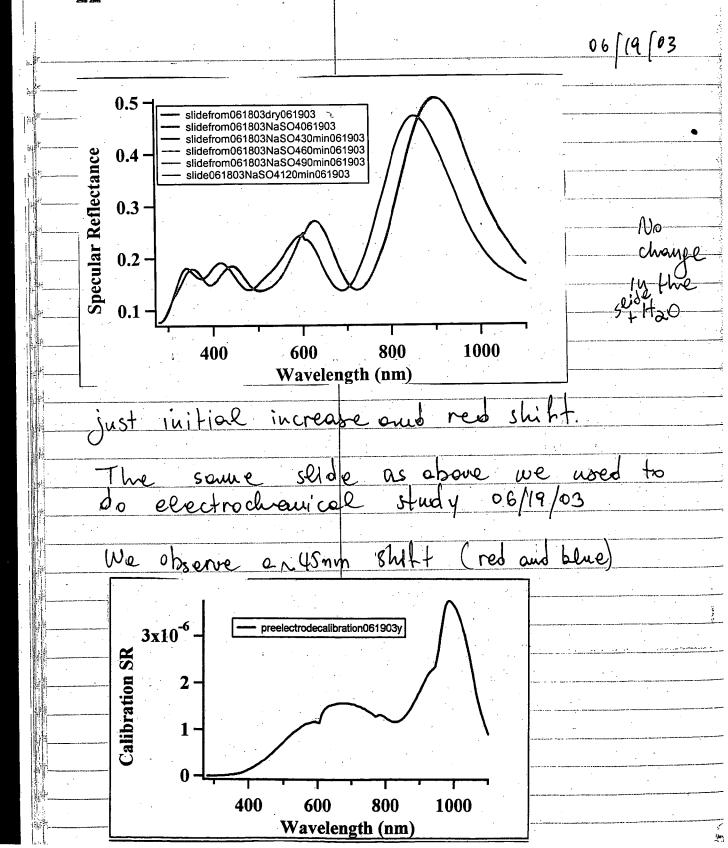
— Dalumina 061903

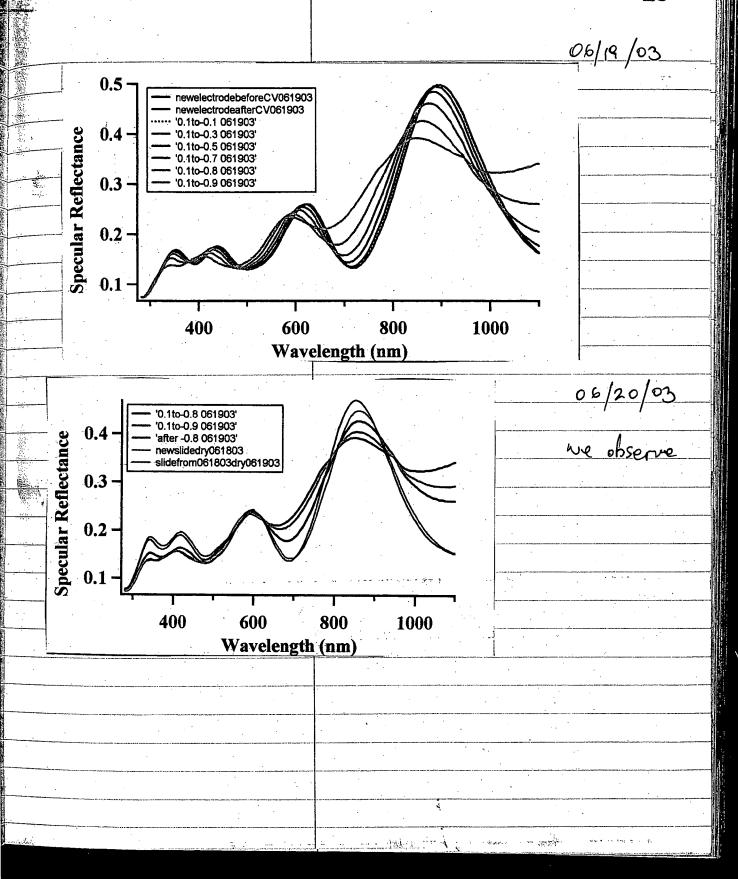
800

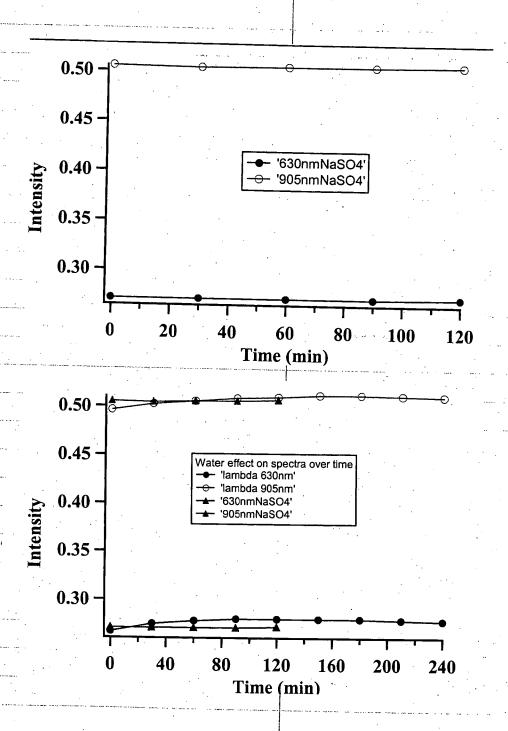
1000

nt 45









06/20/03

